

**Search Notes**

Application/Control No.

10/624,671

Examiner

Helen O. Chu

Applicant(s)/Patent under  
Reexamination

NAKAMURA ET AL.

Art Unit

1795

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Edan and Palm (inventor Search)	11/21/2008	HC
East Search (Search Notes Included)	11/21/2008	HC
NPL	11/21/2008	HC